

SMU-410

4 CHANNEL SMU, $\pm 10\text{V}$, 200mA PER CHANNEL

- 4 isolated SMU channels
- 4-quadrant operation: $\pm 10\text{ V}$, $\pm 200\text{ mA}$
- 7 current ranges, $\pm 200\text{ nA}$ to $\pm 200\text{ mA}$ full scale
- 24-bit ADC's, programmable sampling rate
- 16-bit DAC's for offset and gain adjustments
- Synchronous & asynchronous triggering functions
- Excellent accuracy, from $\pm 0.03\%$ $\pm 2\text{ mV}$
- Supplied with a full featured API and UI
- PXI hybrid slot compatible



DESCRIPTION

The SMU-410 is a precision 3U PXI module that forces and senses both voltage and current over a range of $\pm 10\text{ V}$ and $\pm 200\text{ mA}$. Each of the four channels is independent and electrically isolated from the PXI power supply, chassis, and each other. They may be connected in series providing up to $\pm 40\text{ V}$, or in parallel, providing up to $\pm 800\text{ mA}$.

FEATURES

The SMU-410 employs 16-bit DACs for the sourcing of voltage and current. There are 7 current ranges in decade steps, ranging from $\pm 200\text{ mA FS}$ to $\pm 200\text{ nA FS}$. There is a single voltage range of $\pm 10\text{ V}$. Measurements employ a 24 bit ADC with programmable resolution from 18 to 24 bits. Each output channel includes SMU output connections, Kelvin (sense) connections, and a driven guard connection for low level current measurements.

A dedicated microcontroller for each channel uses nonvolatile memory to store ADC and DAC calibration values as well as the values of each of the 7 current range resistors.

SOFTWARE

The SMU-410 is supplied with a virtual instrument panel, which includes a 32-bit DLL driver. The virtual panel can be used to interactively adjust and control the instrument from a window that displays the instrument's current settings and measurements. Interface files are provided to support a variety of programming tools and languages including ATEasy, Microsoft® and Borland® C/C++, Microsoft Visual Basic®, Borland Delphi, and LabVIEW.

APPLICATIONS

- Semiconductor component test and characterization
- ATE systems
- Board and system level test

SMU-410

SPECIFICATIONS

HARDWARE	
I/O Connections per Channel	SMU input / output (2) Guard Kelvin (2)
Connector	DB 25
Format	PXI, 3U single slot, hybrid slot compatible
SOURCE AND MEASURE SPECIFICATIONS	
Voltage Source	Range: ± 10 V Accuracy: 0.03% of programmed value + 2mV
Current Source	Range: ± 200 nA to ± 200 mA, in decades Accuracy: * $\pm 0.05\%$ of programmed value + 0.05% of FS (for ranges 20 mA or less) $\pm 0.08\%$ of programmed value + 0.05% of FS for 200 mA range
Isolation Voltage	± 100 V relative to PXI ground
Absolute Maximum Voltage within Channel	± 15.5 Volts
Source Noise	20 μ V (0.1 Hz to 10 Hz) 25 mV RMS (20 Hz to 20 MHz)
Settling Time	10% of current range: 10 μ s typical 90% of current range: 100 μ s typical
Transient Response	Settles to ± 20 mV of programmed value after 80% load change, 100 μ s typical
Voltage Measurement	Range: ± 10 V Accuracy: 0.03% of programmed value + 2mV
Current Measurement	Range: ± 200 nA to ± 200 mA, in decades Accuracy: * $\pm 0.05\%$ of programmed value + 0.05% of FS (for ranges 20 mA or less) $\pm 0.08\%$ of programmed value + 0.05% of FS for 200 mA range
Fast DAQ Measurement Functions	AC and DC voltage and current measurements
Measurement Resolution	Programmable, 18 to 24 bits
Measurement Conversion Rate	82 μ s to 2868 μ s, based on measurement resolution
ENVIRONMENTAL AND PHYSICAL SPECIFICATIONS	
Temperature Range	Operating: 0 to +55 °C Storage: -20°C to +70 °C

Power	+5 VDC, 2 A +3.3 VDC, 2 A
Connector	DB 25 female

Note: Specifications are subject to change without notice

ORDERING INFORMATION

SMU-410	4 Channel SMU, ± 10 V, 200mA per Channel
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Note: The SMU-410 is supplied by a 3rd party and resold by Geotest.